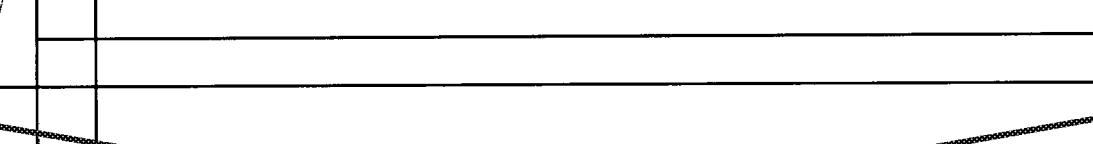


<p>NOV 13 2007 U.S. PATENT AND TRADEMARK OFFICE (Use several sheets if necessary)</p> <p>1449 (Modified)</p> <p>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</p>	Docket No. P0298US-7	Application Number 10/666,399
	Applicants LEUNG, MICHAEL S.	
	Filing Date September 18, 2003	Group Art Unit 2814
	CITE IAP/4 MIE	

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INFORMATION DISCLOSURE CITATION  
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Docket No.  
P0298US-7

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Applicants  
LEUNG, MICHAEL S.

Filing Date  
September 18, 2003

Group Art Unit  
2814

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	5	0	2	7	1	6	8	06/1991	EDMOND	357	17	
	4	9	6	6	8	6	2	10/1990	EDMOND	437	100	
	4	9	1	8	4	9	7	04/1990	EDMOND	357	17	
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	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No

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Date Considered

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FORM PTO-1449 (Modified)

## INFORMATION DISCLOSURE CITATION

IN AN APPLICATION

(See several sheets if necessary)

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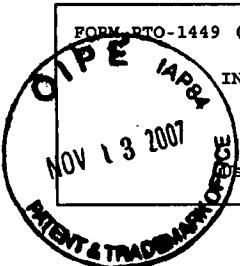
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								Filing Date September 18, 2003	Group Art Unit 2814						

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	6	7	9	1	1	1	9	09/2004	SLATER, JR. et al.	257	99	
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